_ μPD3570 2560-BIT CCD LINEAR IMAGE SENSOR

NEC Electronics Inc.

PRELIMINARY

Description

The µPD3570 is a CCD (charge-coupled device) linear image sensor that changes optical images to electrical signals. It has 2560 photo-elements, 64 optical-black elements, two lines of CCD charge transfer registers, a drive unit, a sample-and-hold circuit, and an output amplifier. The drive unit simplifies the external circuit and reduces total drive power, and the sample-and-hold circuit substantially reduces output signal noise.

The photo-elements have excellent response characteristics because of their PN junction construction. They are $7 \times 5 \mu m$, separated by $2 \mu m$ channel stoppers.

The charge transfer registers feature extremely high transfer efficiencies, above 99.996%.

Features

Clock generator and drive unit on-chip allows
direct drive by +5 V logic system
Excellent photo-electrical characteristics
Optical-black clamp circuit controls dark-level
DC voltage
Sensor reset function controls storage charges
High resolution
Similar response characteristics to those of the

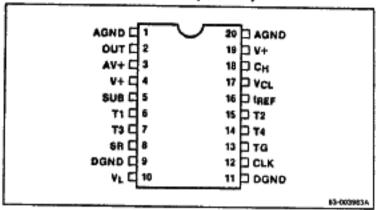
Ordering Information

human eye

Part No.	Package
µPD3570D	20-pin ceramic shrink-DIP

Pin Configuration

20-Pin Ceramic Shrink DIP (300 mil)



Pin Identification

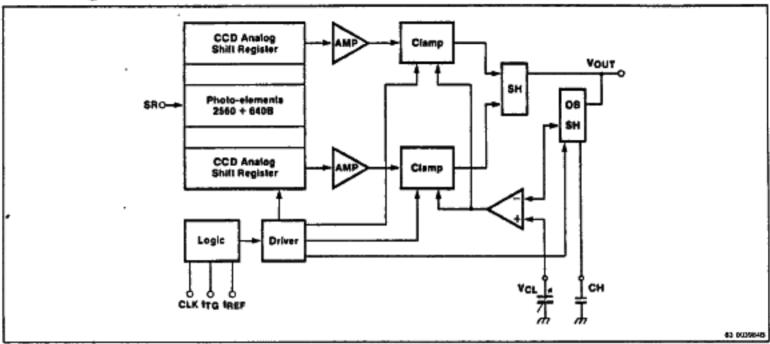
Analog ground Output +12 V analog supply voltage					
+12 V analog supply voltage					
+12 V driver supply voltage Substrate					
Sensor reset					
Digital ground					
+5 V logic supply voltage					
Master clock					
Transfer gate clock					
Reference timing output					
Clamp voltage					
Hold capacitance					

Note:

During normal operation, T1 and T2 should be tied to DGND, and T3 and T4 to \pm 12 V.



Block Diagram



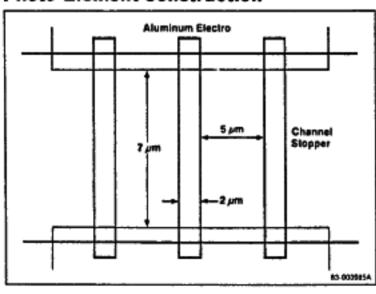
Absolute Maximum Ratings

TA = 25 °C

Driver supply voltage, AV+ or V+	-0.3 to +15 V
Logic supply voltage, V _L	-0.3 to +7 V
Input voltage, pins 6, 7, 8, 14, 15, 17	-0.3 to + 15 V
Input voltage, pins 5, 12, 13	-0.3 to +7 V
Operating temperature range	-25 to +55°C
Storage temperature range	-40 to +100°C

Comment: Exposure to Absolute Maximum Ratings for extended periods may affect device reliability; exceeding the ratings could cause permanent damage.

Photo-Element Construction



Recommended Operating Conditions

 $T_A = -25 \text{ to } +55 ^{\circ}\text{C}$

			Limits			
Parameter	Symbol	Min	Тур	Max	Unit	
Driver supply voltage	V+, AV+	11.4	12.0	12.6	٧	
Logic supply voltage	VL	4.75	5.0	5.25	٧	
Substrate voltage	V _{SUB}	4.75	5.0	5.25	٧	
Sensor reset ON voltage	V _{SR} (on)	11	12		٧	
Sensor reset OFF voltage	V _{SR} (off)	1.5	2.5	3.5	v	
Input voltage, high	VINH	2.4			٧	
Input voltage, low	VINL			0.5	٧	
Master clock frequency	CLK	0.2	1.0	3.0	MHz	
TG clock	trg	2t (Note 1)		10	μS	
Clamp voltage	V _{CL}	3.0	3.5	4.0	V	
Hold capacitance	Сн	2.2	4.7	10	μF	

Note:

(1) t = 1/CLK Test pin voltage T1 = T2 = 0 V Test pin voltage T3 = T4 = +12 V



DC Characteristics

 $T_A = 25$ °C; V+ = AV+ = 12 V; $V_L = +5$ V; $V_{SR} = 1$ V; $V_{CL} = 3$ V; $C_H = 4.7 \, \mu F$; $t_{CLK} = 1$ MHz; $t_{TG} = 4 \, \mu s$; $t_{STO} = 5 \, ms$

			Limits			
Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions
Clock input capacitance	CCLK		10		pF	
Clock input leakage current	†LCLK		1	10	μА	V _{IN} = 5 V
Output voltage, high	VoH	3.5	4.5	5.0	٧	R _L = 5 k; OUT—GND
Output voltage, low	V _{OL}		0.2	0.8	v	R _L = 5 k; OUT—VDG
Sensor reset capacitance	CSR		100		pF	
Sensor reset current	Isa			100	μA	No transients
Test leakage current .	JLTEST		1	10	μA	- Pins 7, 14
Clamp leakage current	ILCLAMP		1	10	μA	
Substrate current	lsua l		10	100	μA	V _{SUB} = 5 V
Analog supply current	Al+	5	8	12	mA	Pin 3
Driver supply current	l+	5	8	12	mA	Pins 4, 19 total
Logic supply current	l <u>l</u>	20	35	60	mA	
Output signal impedance	Z ₀		0.5	1.5	kΩ	
Clamp offset voltage	V _{CL(os)}	-70	0	+80	mV	V ₀₈ V _{CL} at V _{CL} = 3 V
Output saturation voltage	V _{0(sat)}	2.5	3.5	4.5	٧	-02
Saturation exposure SE			0.83 2.50		lx.s lx.s	2856 K tungsten famp White fluorescent
Photo-response non-uniformity			±5	±10	%	V _{OUT} = 2 V, 3200 K
Average dark signal			2	10	mV	See timing chart
Dark signal non-uniformity			2	15	m∀	
Sensitivity		3.0 0.98	4.2 1.4	5.4 1.82	V/Ix.s V/Ix.s	2856 K tungsten lamp White fluorescent

Sensor Reset

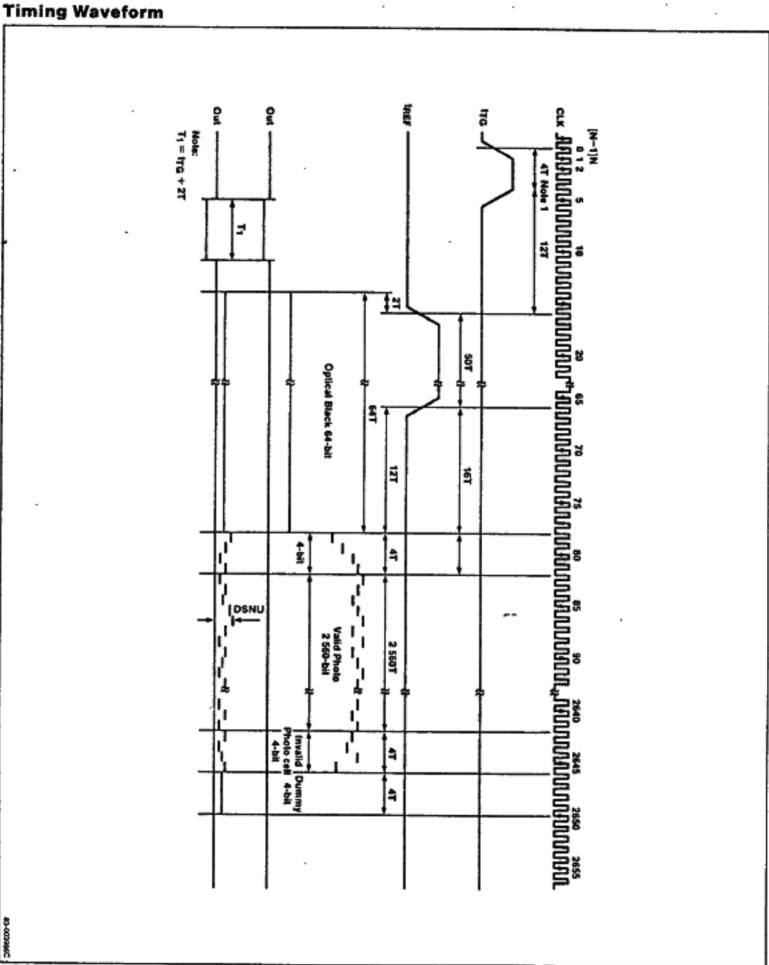
Sensor reset is a function that controls the signal charge generated by the photo-electric conversion of the photo-transistors. The following timing diagram shows the relationship between SR and the transfer gate timing signal (trg).

Note that when SR is held low, the storage time is determined strictly by trg, and is defined to be the time between falling edges of successive trg pulses (shown in the drawing as tSTO1).

With SR high, the storage time is defined as the time between the falling edge of the SR pulse and the falling edge of the t_{TG} pulse. Thus, storage time is controlled by the width of the SR pulse.

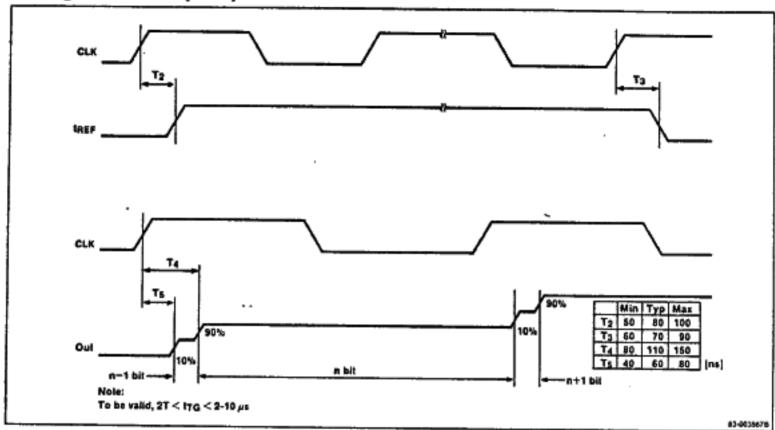
Using the SR function, the output signal can be held at a fixed level, even if the input varies.

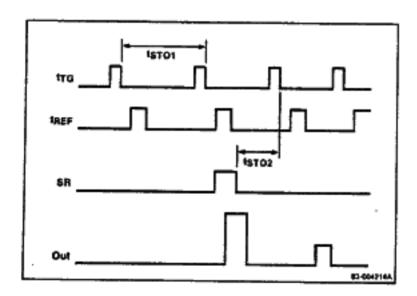






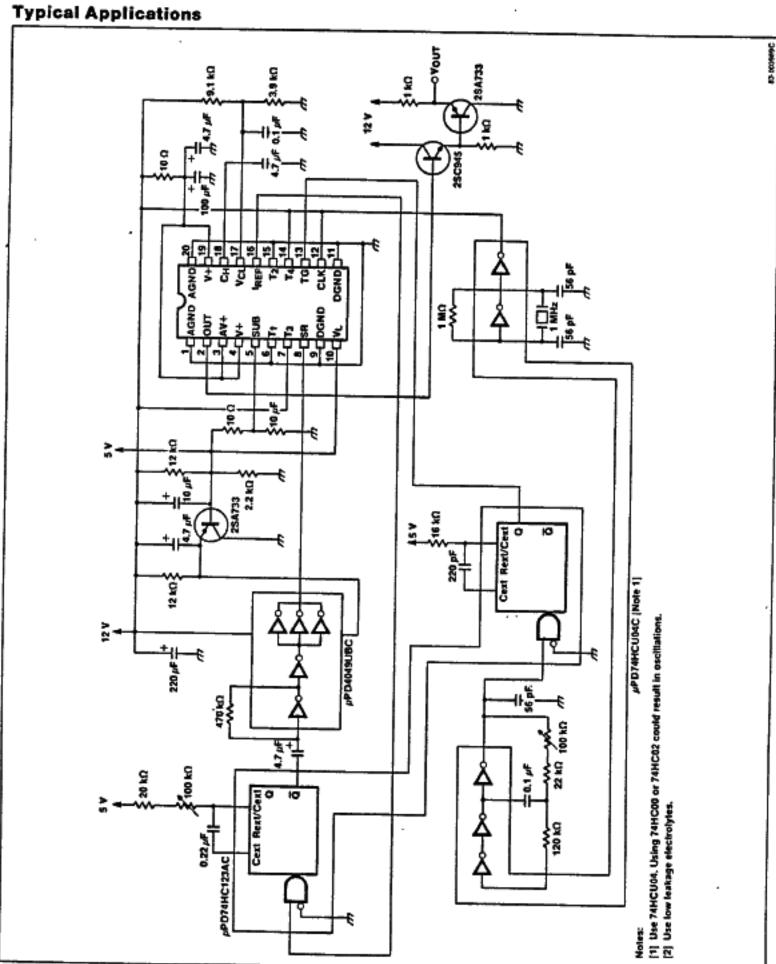
Timing Waveforms (cont)





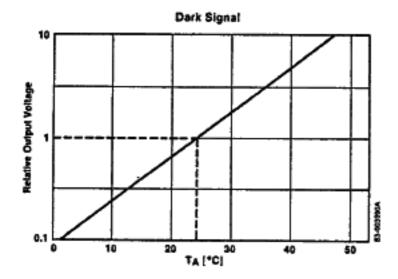


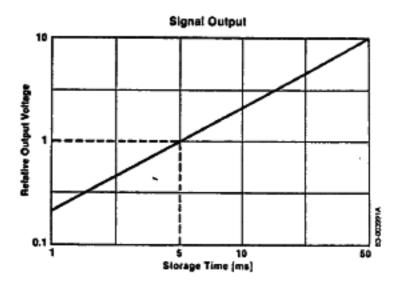


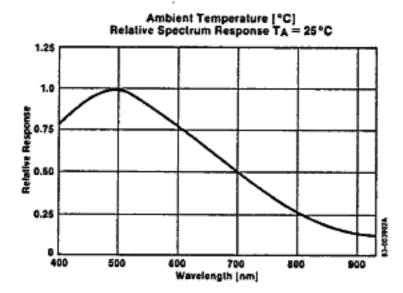




Operating Characteristics T_A = 25°C









Application Notes

Electrostatic Damage

Normal precautions for MOS devices should be taken.

Surge Voltages

The power supply pins (pins 3, 4, 14) can be easily damaged by surge voltages. Use normal current limiting and bypass techniques.

Sensor Reset

Voltage applied to this pin must not be allowed to fall below 1.5 V. Serious damage to the device could result. Orive signal must be pulsed. Driving the SR pin by anything other than a pulse will change the characteristics of the device. Drive pulse to the SR pin should be applied after the leading edge of the t_{TG} pulse.

Window Glass

If some dust gets on the glass it is possible that the resultant output signal may be misinterpreted as a black level signal. So the surface of the glass must always be kept clean. Avoid abrasives and strong chemicals; if glass needs to be cleaned, use soap and water and wipe with a soft cloth.

Ambient Temperature

The dark current of the device is very temperature sensitive, so care must be taken to ensure a constant ambient temperature.

Substrate Pin

+5 power should be applied prior to the application of +12 V.